

General Description

It combines planar MOSFET technology with a low resistance package to provide low $R_{DS(ON)}$.

Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

Application

- BLDC Motor driver
- DC-DC
- Load Switch

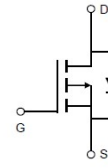
Ordering Information:

Part NO.	ZMPA02P50P
Marking	ZMP02P50
Packing Information	TUBE BULK
Basic ordering unit (pcs)	1000

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-Source Voltage	V_{DS}		-	-500	V
Gate-Source Voltage	V_{GS}		-20	20	V
Continuous Drain Current	I_D	$V_{GS}=-10\text{V}, T_C=25^{\circ}\text{C}$	-	-4.7	A
	I_D	$V_{GS}=-10\text{V}, T_C=75^{\circ}\text{C}$	-	-3.8	A
	I_D	$V_{GS}=-10\text{V}, T_C=100^{\circ}\text{C}$	-	-3.3	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}; T_C = 25^{\circ}\text{C};$	-	-18.8	A
Total Power Dissipation	P_D	$T_C=25^{\circ}\text{C}$	-	167	W
Total Power Dissipation	P_D	$T_A=25^{\circ}\text{C}$	-	2.4	W
Operating Junction Temperature	T_J		-55	175	$^{\circ}\text{C}$
Storage Temperature	T_{STG}		-55	175	$^{\circ}\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=5\text{mH}, V_{GS}=-10\text{V}, R_g=25\Omega,$	-	160	mJ
ESD Level (HBM)	CLASS 2				

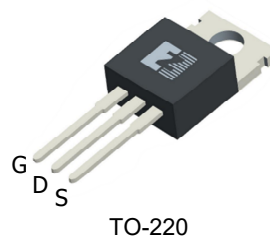
Product Summary



$$V_{DS} = -500\text{V}$$

$$R_{DS(ON)} = 3000\text{m}\Omega$$

$$I_D = -4.7\text{A}$$



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction-case	R_{thJC}	-	-	0.9	°C/W
Thermal resistance, junction-ambient ^①	R_{thJA}	-	-	62	°C/W
Soldering temperature	T_{sold}	-	-	260	°C

•Electronic Characteristics (T_J=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-500	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-3	-4.3	-5	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=-500V, T_J=25^\circ C$	-	-	-1.0	μA
		$V_{GS}=0V, V_{DS}=-500V, T_J=175^\circ C$	-	-	-100	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-2A, T_J=25^\circ C$	-	3000	3600	m Ω
		$V_{GS}=-10V, I_D=-2A, T_J=175^\circ C$	-	7123	-	m Ω
Forward Transconductance	g_{FS}	$V_{DS}=-20V, I_D=-2A$	-	4.3	-	S
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=-2A$	-	-	-1.3	V

•Dynamic characteristics (T_J=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=-250V, V_{GS}=0V$	-	848	-	pF
Output capacitance	C_{oss}		-	30	-	
Reverse transfer capacitance	C_{rss}		-	4	-	
Gate Resistance	R_g	$f=1MHz, V_{GS}=0V$	-	10	-	Ω
Total gate charge	Q_g	$V_{DD}=-250V, I_D=-2A, V_{GS}=-10V$	-	15.6	-	nC
Gate - Source charge	Q_{gs}		-	4.8	-	
Gate - Drain charge	Q_{gd}		-	5.0	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=-10V, V_{DS}=-250V, R_G=3.3\Omega, I_D=-2A$	-	16	-	ns
Turn-ON Rise time	t_r		-	73	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	46	-	ns
Turn-Off Fall time	t_f		-	59	-	ns
Reverse Recovery Time	t_{rr}	$V_{DD}=-250V, dI_S/dt=100A/\mu s, I_S=-2A$	-	351	-	ns
Reverse Recovery Charge	Q_{rr}		-	1950	-	nC

Fig.1 Gate-source voltage as a function of gate charge; Typical values; $T_j=25^\circ\text{C}$

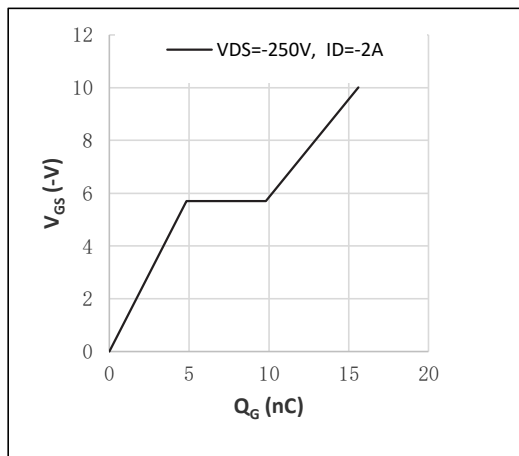


Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

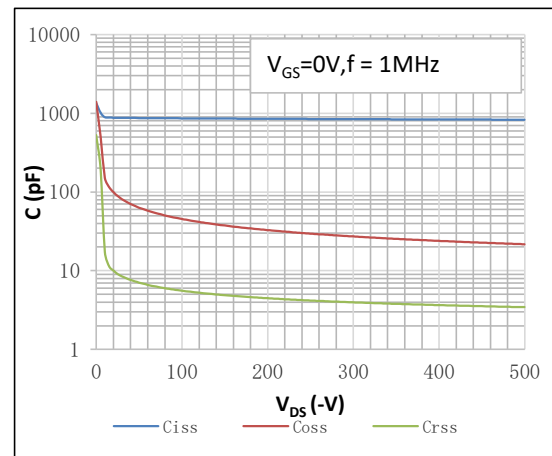


Fig.3 Output characteristics: drain current as a function of drain-source voltage; Typical values; $T_j=25^\circ\text{C}$

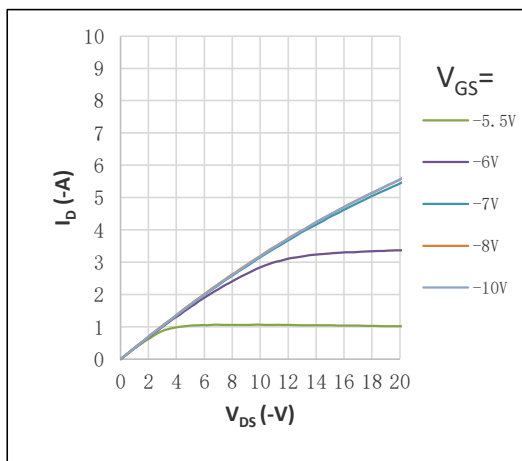


Fig.4 Output characteristics: drain current as a function of drain-source voltage; Typical values; Expanded curve; $T_j=25^\circ\text{C}$

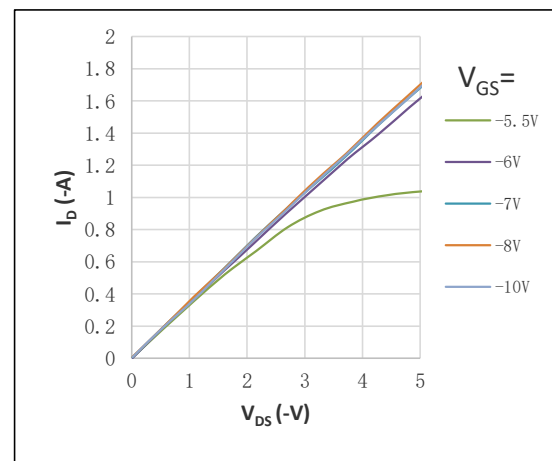


Fig.5 Gate-source threshold voltage as a function of junction temperature; Typical values

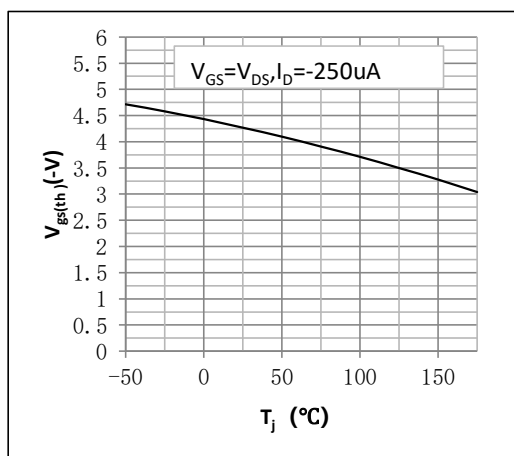


Fig.6 Drain-source on-state resistance as a function of drain current; Typical values; $T_j=25^\circ\text{C}$

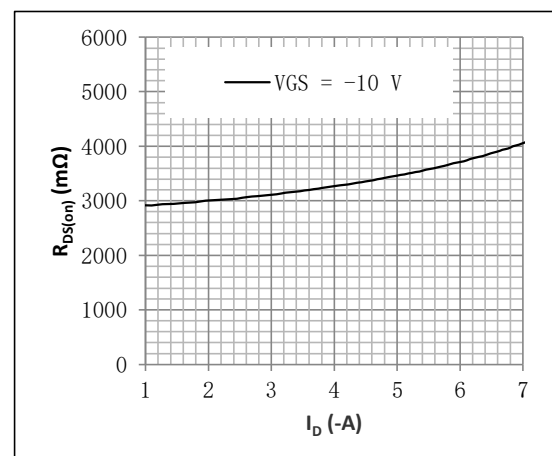


Fig.7 Drain-source on-state resistance as a function of gate-source voltage;Typical values

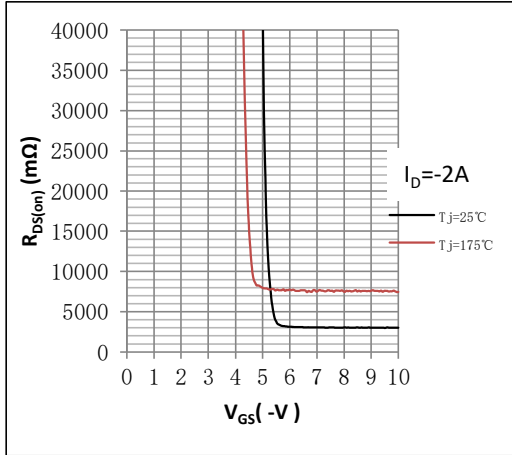


Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage ;Typical values

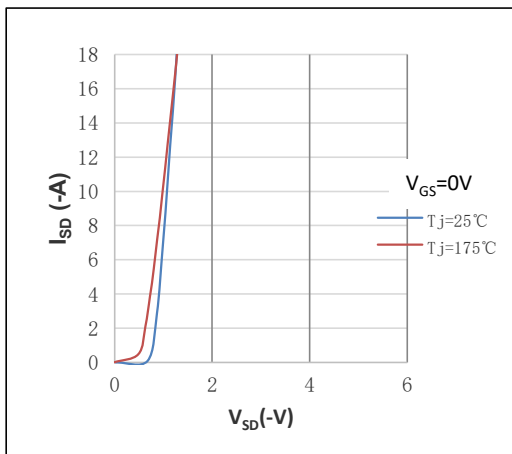


Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage;Calculative values

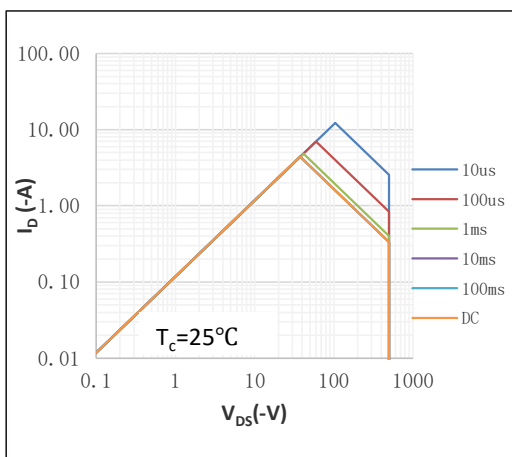


Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature;Typical values
Normalized On-Resistance= $R_{DS(on)}/R_{DS(on)}(25^{\circ}\text{C})$

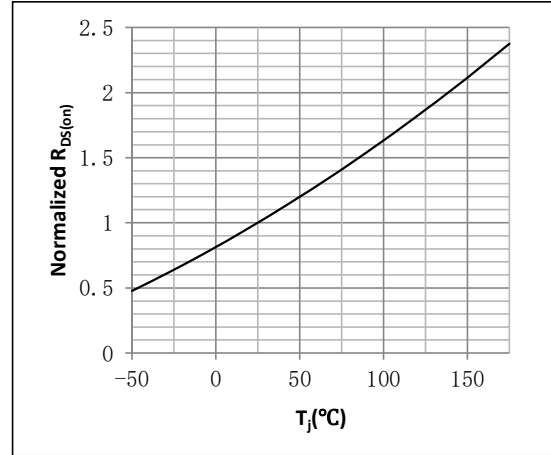


Figure 10. Transfer characteristics: drain current as a function of gate-source voltage;Typical values

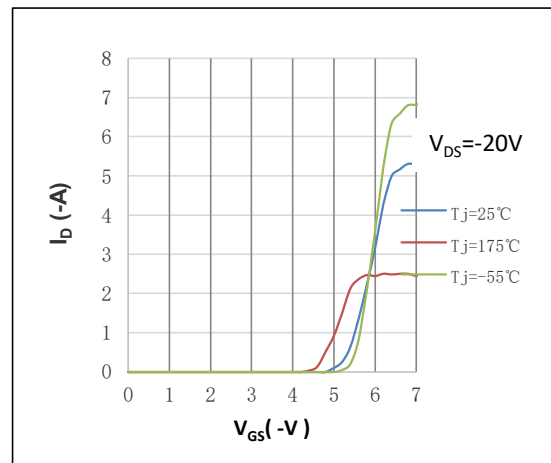


Fig.12 Continuous drain current as a function of case temperature[®];Calculative values

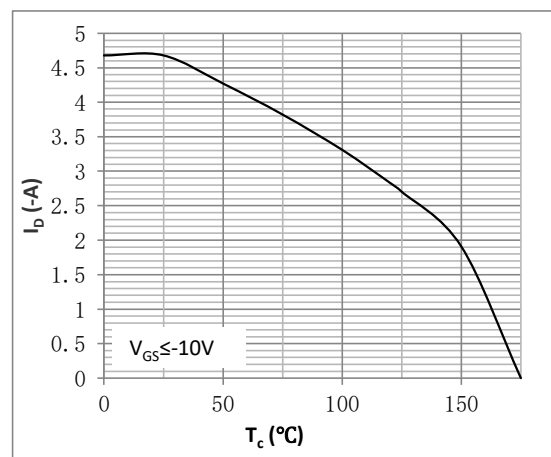


Fig.13 Drain-source breakdown voltage as a function of junction temperature; Typical values
Normalized BVDSS=BVDSS/BVDSS(25°C)

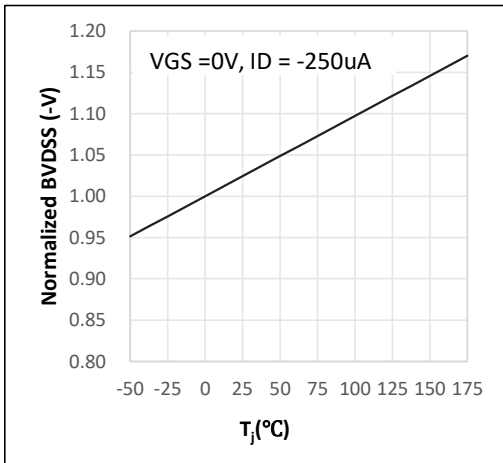


Fig.14 Normalized total power dissipation as a function of case temperature; Calculative values
Normalized Power Dissipation= $P_d/P_d(25^\circ C)$

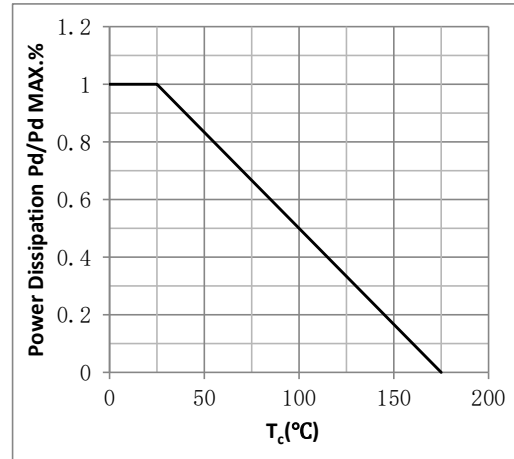
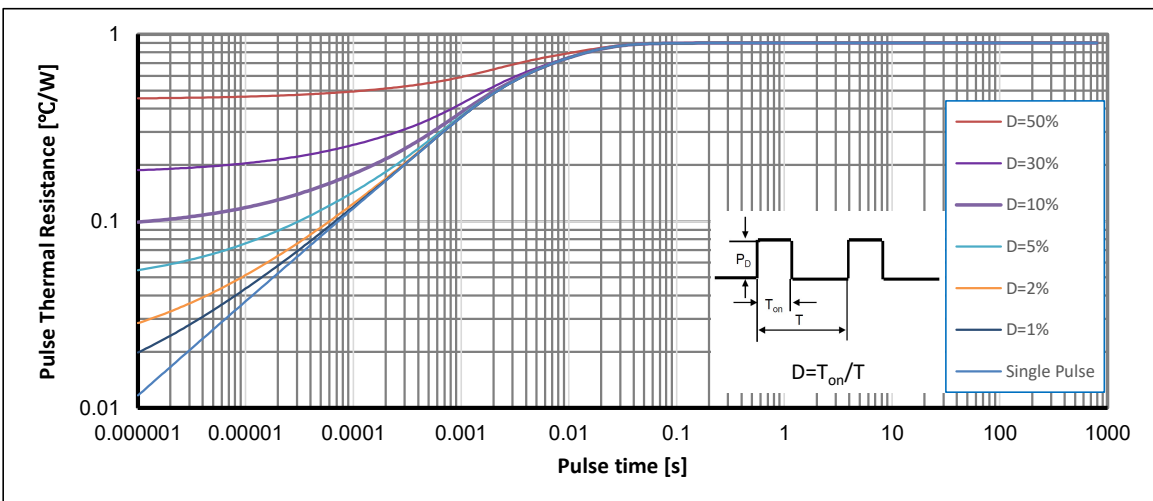
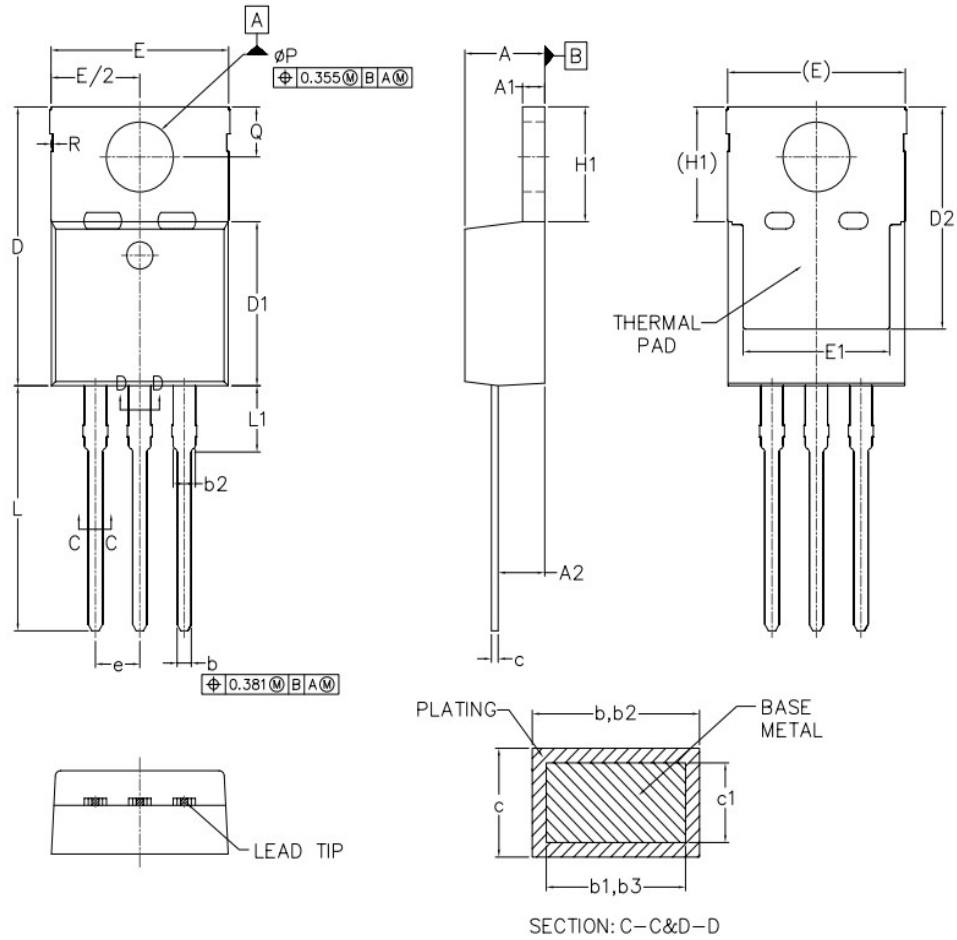


Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values



•TO-220 Package Outline



SYMBOL	COMMON	
	MM	
	MIN.	MAX.
A	3.556	4.826
A1	0.508	1.397
A2	2.032	2.921
b	0.381	1.016
b1	0.381	0.965
b2	1.143	1.778
b3	1.143	1.727
c	0.356	0.610
c1	0.356	0.559
D	14.224	16.510
D1	8.382	9.017
D2	12.042	12.878
E	9.652	10.668
E1	6.858	8.890
e	2.540	BSC.
H1	5.842	6.858
L	12.700	14.732
L1	3.560	4.060
ϕP	3.810	3.860
Q	2.540	3.048
R	0.127	BSC.

Note:

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS} = -10V$.

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Revision History

Version	Date	Change
A	2025/6/21	New